

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/646,918	KIM, YOUNG-SE	
Examiner	Art Unit	
Huy D. Nguyen	2681	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	566	8/3/2005	HN
	90.3		
	575.1		
	550.1		
	575.4		
	575.8		
348	207.1	İ	

INT	ERFERENC	RFERENCE SEARCHED		
Class	Subclass	Date	Examiner	
			<u> </u>	
	<u> </u>			

(INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
455 and 379 (USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB) - Text Search - See Search History Printout (Power outage on 8/3)	8/3/2005	HN
	,	